

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
10629319	07/29/2003	360	324.110	2653	HEINZ, A

****APPLICANTS:** Hardayal Gill; Wen-Chien Hsiao; Jih-Shiuan Luo;

****CONTINUING DATA VERIFIED:**

**** FOREIGN APPLICATIONS VERIFIED:**

PG-PUB	DO NOT PUBLISH <input type="checkbox"/>	RESCIND <input type="checkbox"/>	
Foreign priority claimed	<input type="checkbox"/> yes <input checked="" type="checkbox"/> no	ATTORNEY DOCKET NO	
35 USC 119 conditions met	<input type="checkbox"/> yes <input type="checkbox"/> no	HSJ920030016US1 (HITG.023	
Verified and Acknowledged Examiners's initials	<i>SH</i>		
TITLE : Method and apparatus for enhancing thermal stability, improving biasing and reducing damage from electrostatic discharge in self-pinned abutted junction. Leads having self-pinned laye			
U.S. DEPT. OF COMM./PAT. & TM-PTO-436L (Rev. 12-94)			